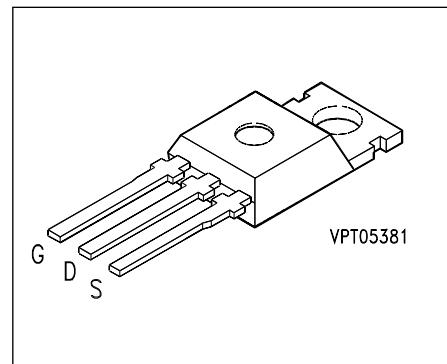


SIPMOS® Power Transistors

BUZ 73
BUZ 73 A

- N channel
- Enhancement mode
- Avalanche-rated



Type	V_{DS}	I_D	T_c	$R_{DS\ (on)}$	Package ¹⁾	Ordering Code
BUZ 73	200 V	7.0 A	28 °C	0.4 Ω	TO-220 AB	C67078-S1317-A2
BUZ 73 A	200 V	5.5 A	37 °C	0.6 Ω	TO-220 AB	C67078-S1317-A3

Maximum Ratings

Parameter	Symbol	BUZ		Unit
		73	73 A	
Continuous drain current	I_D	7.0	5.5	A
Pulsed drain current, $T_c = 25$ °C	$I_{D\ puls}$	28	22	
Avalanche current, limited by $T_{j\ max}$	I_{AR}	7.0		
Avalanche energy, periodic limited by $T_{j\ (max)}$	E_{AR}	6.5		mJ
Avalanche energy, single pulse $I_D = 7$ A, $V_{DD} = 50$ V, $R_{GS} = 25$ Ω $L = 3.67$ mH, $T_j = 25$ °C	E_{AS}	120		
Gate-source voltage	V_{GS}	± 20		V
Power dissipation, $T_c = 25$ °C	P_{tot}	40		W
Operating and storage temperature range	T_j, T_{stg}	– 55 ... + 150		°C

Thermal resistance, chip-case	$R_{th\ JC}$	≤ 3.1	K/W
DIN humidity category, DIN 40 040	–	E	–
IEC climatic category, DIN IEC 68-1	–	55/150/56	

1) See chapter Package Outlines.

Electrical Characteristics

at $T_j = 25^\circ\text{C}$, unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Static characteristics

Drain-source breakdown voltage $V_{GS} = 0 \text{ V}, I_D = 0.25 \text{ mA}$	$V_{(\text{BR})\text{DSS}}$	200	–	–	V
Gate threshold voltage $V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	$V_{GS\text{(th)}}$	2.1	3.0	4.0	
Zero gate voltage drain current $V_{DS} = 200 \text{ V}, V_{GS} = 0 \text{ V}$ $T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	I_{DSS}	–	0.1	1.0	μA
–	–	–	10	100	
Gate-source leakage current $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	I_{GSS}	–	10	100	nA
Drain-source on-resistance $V_{GS} = 10 \text{ V}, I_D = 4.5 \text{ A}$ BUZ 73	$R_{DS\text{(on)}}$	–	0.3	0.4	Ω
BUZ 73 A		–	0.5	0.6	

Dynamic characteristics

Forward transconductance $V_{DS} \geq 2 \times I_D \times R_{DS\text{(on)max}}, I_D = 4.5 \text{ A}$	g_{fs}	3.0	4.2	–	S
Input capacitance $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	C_{iss}	–	400	530	pF
Output capacitance $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	C_{oss}	–	85	130	
Reverse transfer capacitance $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	C_{rss}	–	45	70	
Turn-on time t_{on} , ($t_{on} = t_{d\text{(on)}} + t_r$) $V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3.0 \text{ A}, R_{GS} = 50 \Omega$	$t_{d\text{(on)}}$	–	10	15	ns
	t_r	–	40	60	
Turn-off time t_{off} , ($t_{off} = t_{d\text{(off)}} + t_f$) $V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3.0 \text{ A}, R_{GS} = 50 \Omega$	$t_{d\text{(off)}}$	–	55	75	
	t_f	–	30	40	

Electrical Characteristics (cont'd)
at $T_j = 25^\circ\text{C}$, unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

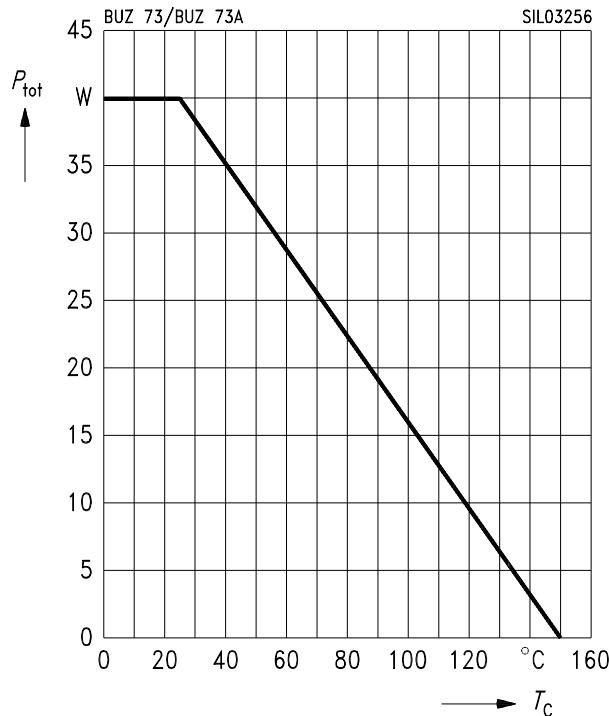
Reverse diode

Continuous reverse drain current $T_C = 25^\circ\text{C}$ BUZ 73 BUZ 73 A	I_S	— —	— —	7.0 5.5	A
Pulsed reverse drain current $T_C = 25^\circ\text{C}$ BUZ 73 BUZ 73 A	I_{SM}	— —	— —	28 22	
Diode forward on-voltage $I_S = 14 \text{ A}$, $V_{GS} = 0 \text{ V}$	V_{SD}	—	1.3	1.7	V
Reverse recovery time $V_R = 100 \text{ V}$, $I_F = I_S$, $di_F / dt = 100 \text{ A}/\mu\text{s}$	t_{rr}	—	200	—	ns
Reverse recovery charge $V_R = 100 \text{ V}$, $I_F = I_S$, $di_F / dt = 100 \text{ A}/\mu\text{s}$	Q_{rr}	—	0.60	—	μC

Characteristics at $T_j = 25^\circ\text{C}$, unless otherwise specified.

Total power dissipation

$$P_{\text{tot}} = f(T_C)$$

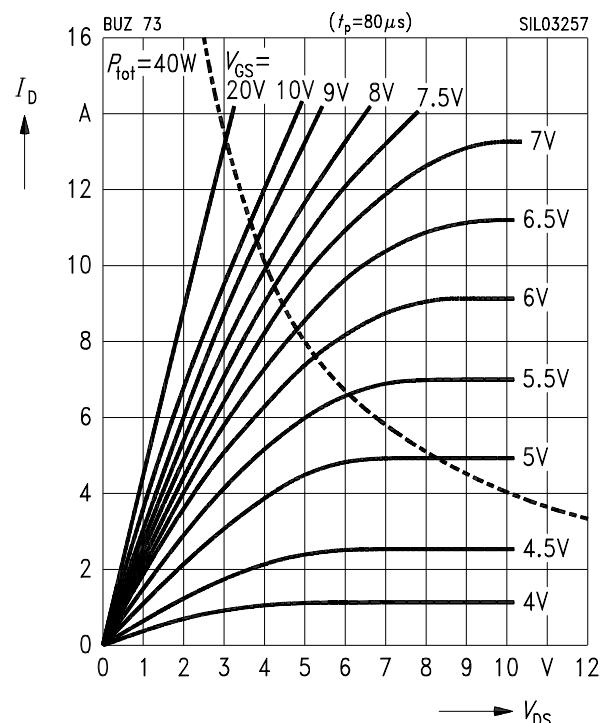


Typ. output characteristics

$$I_D = f(V_{DS})$$

parameter: $t_p = 80 \mu\text{s}$

BUZ 73

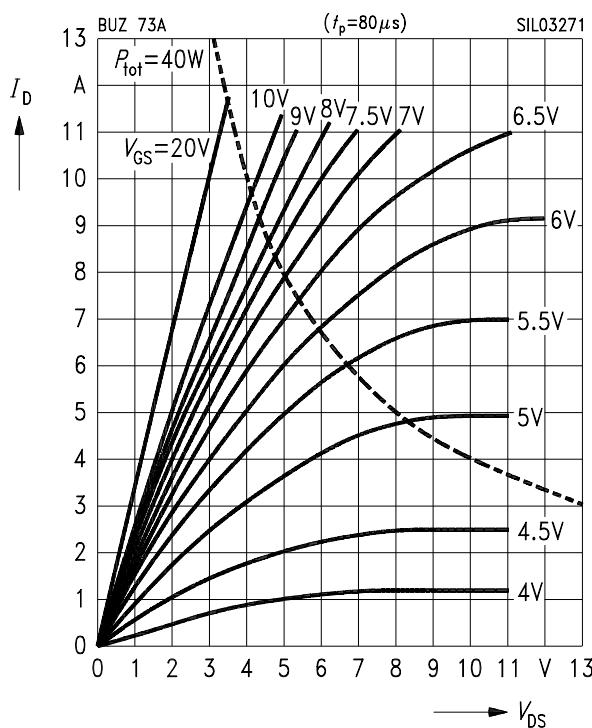


Typ. output characteristics

$$I_D = f(V_{DS})$$

parameter: $t_p = 80 \mu\text{s}$

BUZ 73 A

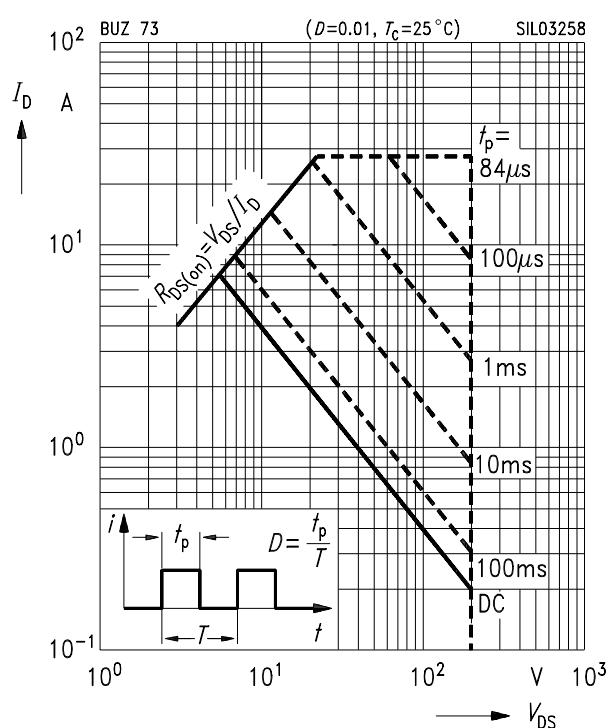


Safe operating area

$$I_D = f(V_{DS})$$

parameter: $D = 0.01, T_C = 25^\circ\text{C}$

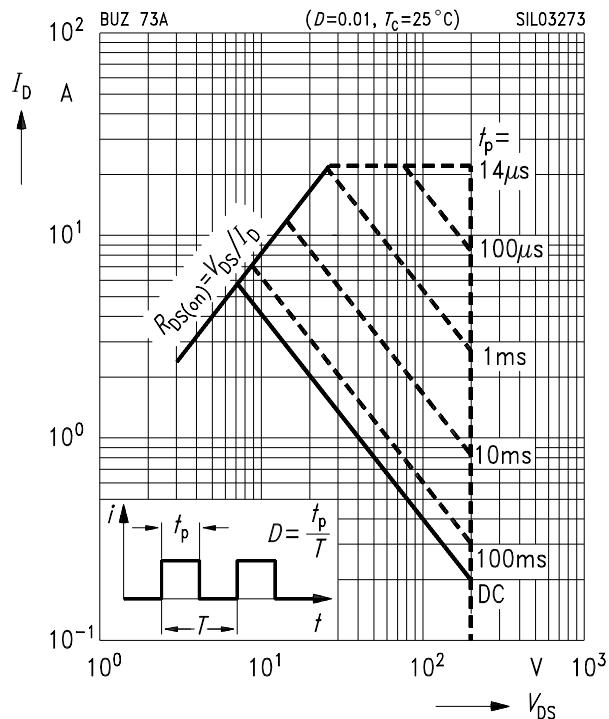
BUZ 73



Safe operating area

$$I_D = f(V_{DS})$$

parameter: $D = 0.01$, $T_C = 25^\circ\text{C}$

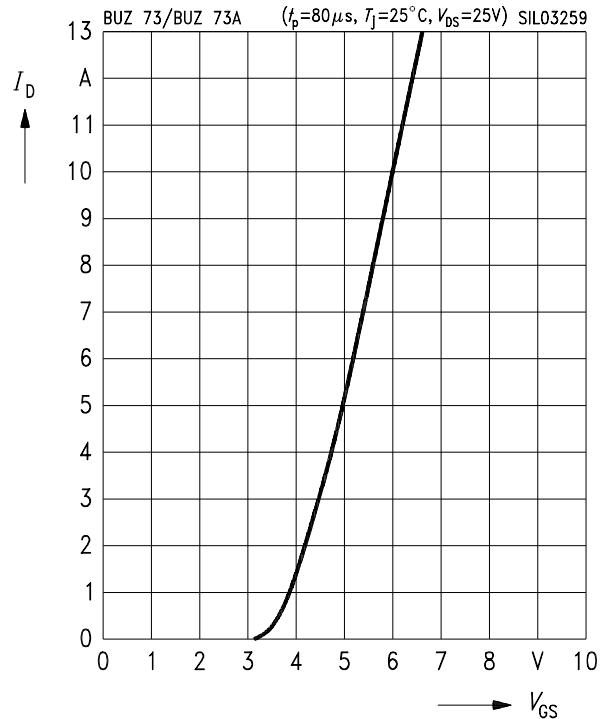


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Typ. transfer characteristics

$$I_D = f(V_{GS})$$

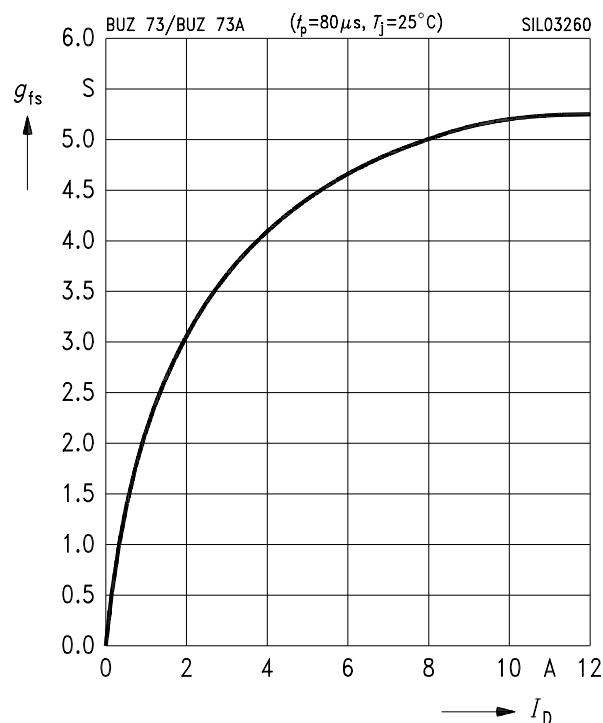
parameter: $t_p = 80\mu\text{s}$, $V_{DS} = 25\text{ V}$



Typ.forward transconductance

$$g_{fs} = f(I_D)$$

parameter: $t_p = 80\mu\text{s}$

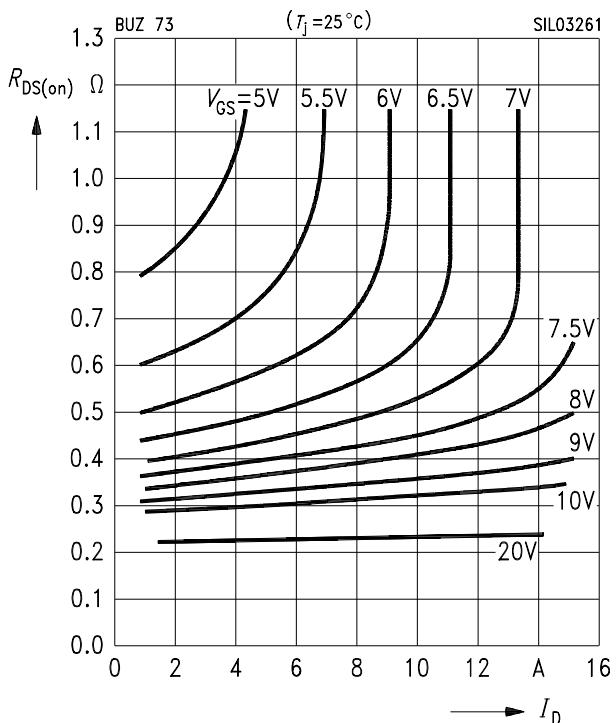


Typ. drain-source on-resistance

$$R_{DS(on)} = f(I_D)$$

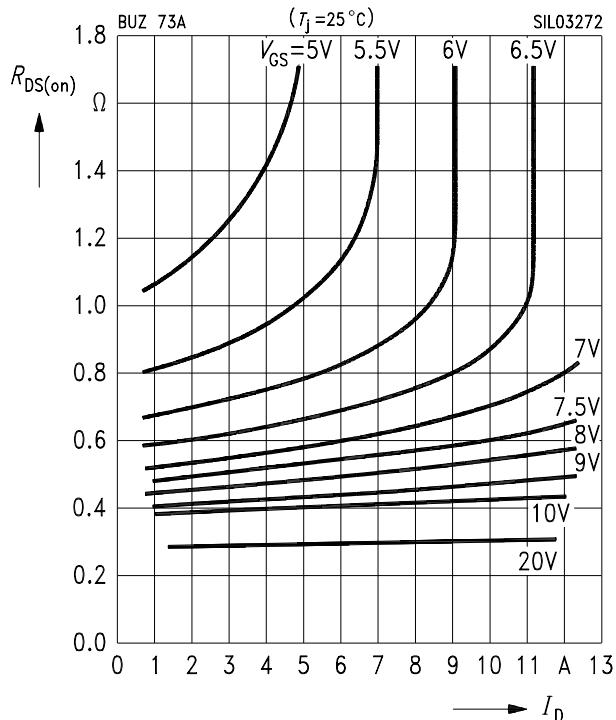
parameter: V_{GS}

BUZ 73



Typ. drain-source on-resistance

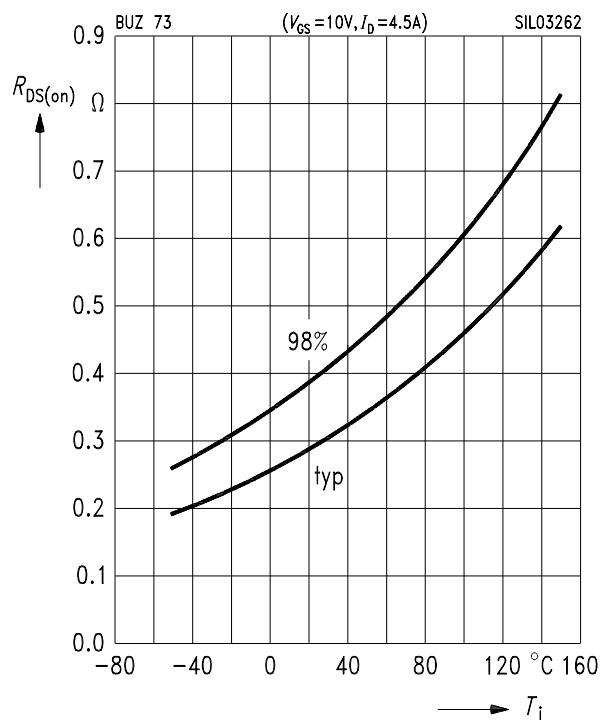
$R_{DS(on)} = f(I_D)$
parameter: V_{GS}



BUZ 73 A

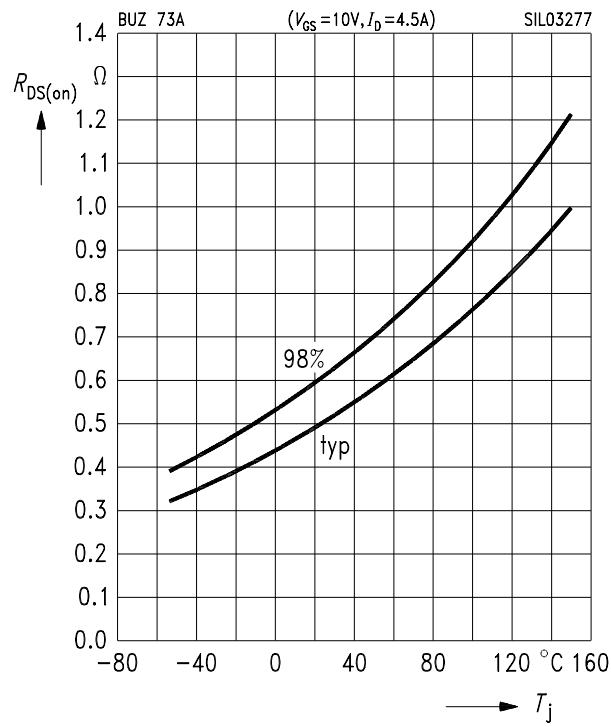
Drain-source on-resistance

$R_{DS(on)} = f(T_j)$
parameter: $I_D = 4.5$ A, $V_{GS} = 10$ V, (spread)



Drain-source on-resistance

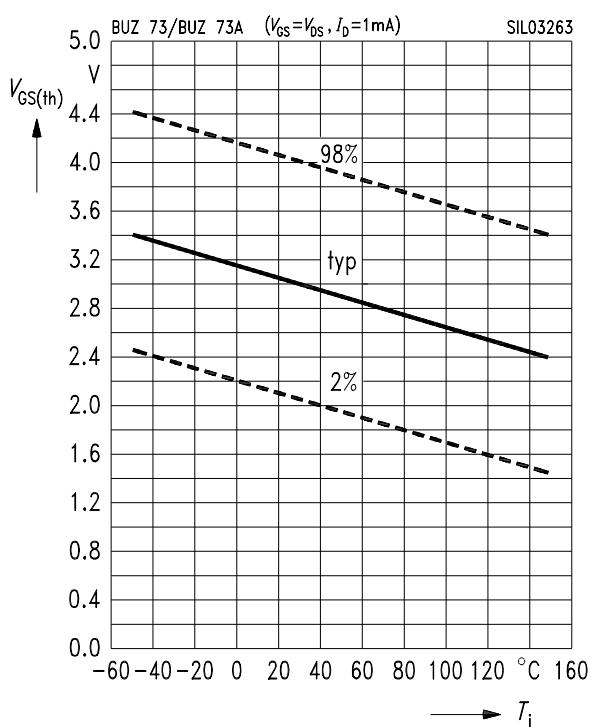
$R_{DS(on)} = f(T_j)$
parameter: $I_D = 4.5$ A, $V_{GS} = 10$ V, (spread)



BUZ 73 A

Gate threshold voltage

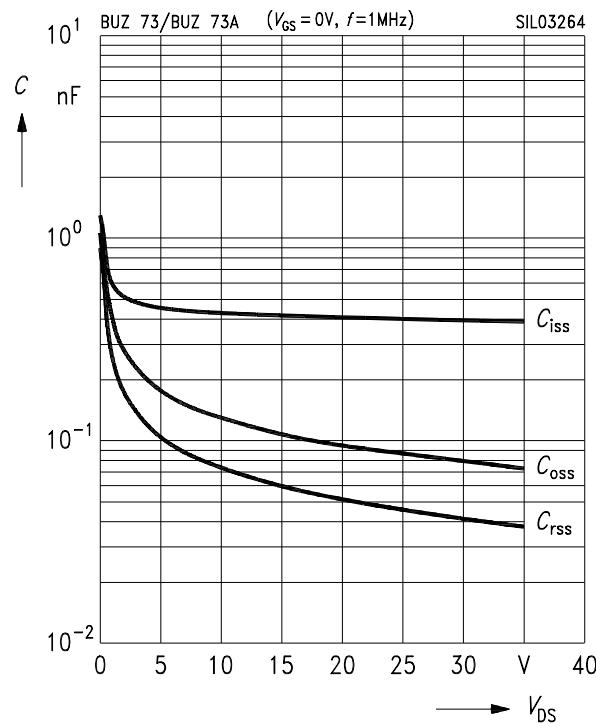
$V_{GS(th)} = f(T_j)$
parameter: $V_{GS} = V_{DS}$, $I_D = 1$ mA, (spread)



Typ. capacitances

$$C = f(V_{DS})$$

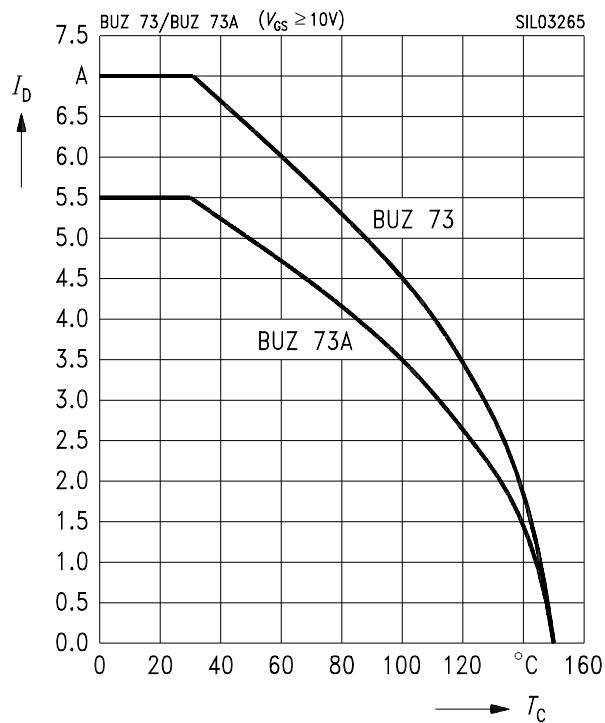
parameter: $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$



Drain current

$$I_D = f(T_C)$$

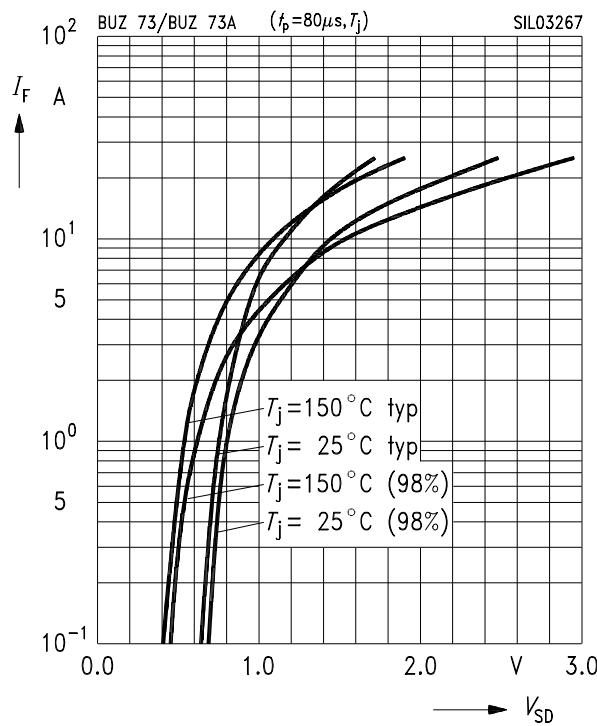
parameter: $V_{GS} \geq 10 \text{ V}$



Forward characteristics of reverse diode

$$I_F = f(V_{SD})$$

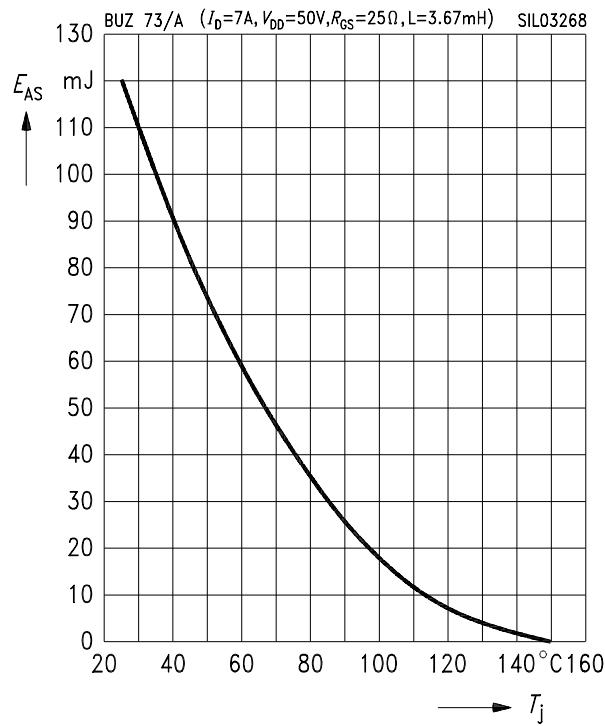
parameter: T_j , $t_p = 80 \mu\text{s}$



Avalanche energy $E_{AS} = f(T_j)$

parameter: $I_D = 7 \text{ A}$, $V_{DD} = 50 \text{ V}$

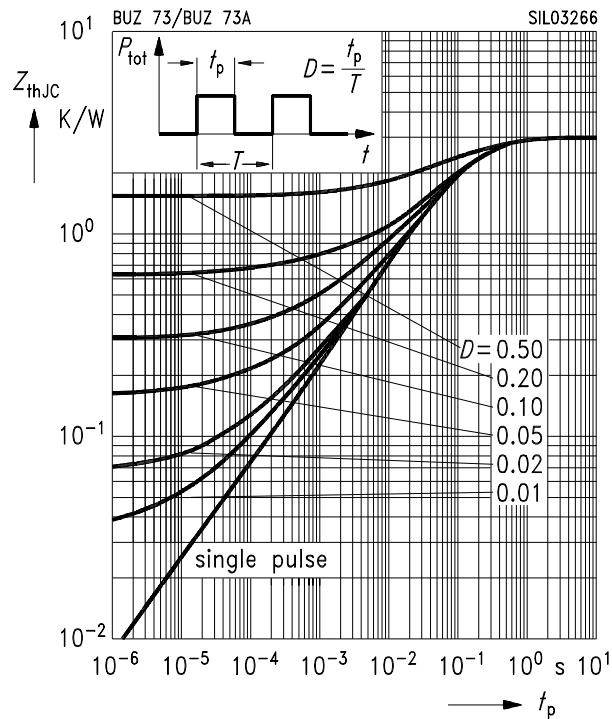
$R_{GS} = 25 \Omega$, $L = 3.67 \text{ mH}$



Transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

parameter: $D = t_p / T$



Typ. gate charge

$$V_{\text{GS}} = f(Q_{\text{Gate}})$$

parameter: $I_{D \text{ puls}} = 13.5 \text{ A}$

